

## SI5404DC-T1-E3-VB Datasheet N-Channel 30-V (D-S) MOSFET

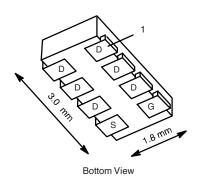
PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A)		
30	0.029 at V <sub>GS</sub> = 10 V	6.7		
30	0.035 at V <sub>GS</sub> = 4.5 V	6.1		

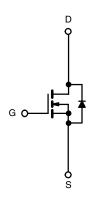
#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Available
- Trench Power MOSFET









N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b>	T <sub>A</sub> = 25 °C, unle	ss otherwise r	noted´		
Parameter		Symbol	5 s	Steady State	Unit
Drain-Source Voltage		V <sub>DS</sub>	30		V
Gate-Source Voltage		$V_{GS}$	± 20		
Outlines Project Outline (T. 450.00)	T <sub>A</sub> = 25 °C	- I <sub>D</sub>	6.7	4.9	
Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a</sup>	T <sub>A</sub> = 85 °C		4.8	3.5	^
Pulsed Drain Current		I <sub>DM</sub>	20		Α
Continuous Source Current (Diode Conduction) <sup>a</sup>		I <sub>S</sub>	2.1	1.1	
	T <sub>A</sub> = 25 °C	P <sub>D</sub>	2.5	1.3	W
Maximum Power Dissipation <sup>a</sup>	T <sub>A</sub> = 85 °C		1.3	0.7	VV
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150		°C
Soldering Recommendations (Peak Temperature) <sup>b, c</sup>			260		-0

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Manipulation to Applicant	t ≤ 5 s	$R_{thJA}$	45	50		
Maximum Junction-to-Ambient <sup>a</sup>	Steady State	' 'thJA	80	95	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	$R_{thJF}$	18	22		

## Notes:

- a. Surface Mounted on 1" x 1" FR4 board.
- b. See Reliability Manual for profile. The DFN3X2 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- c. Rework Conditions: manual soldering with a soldering iron is not recommended for leadless components.

服务热线:400-655-8788

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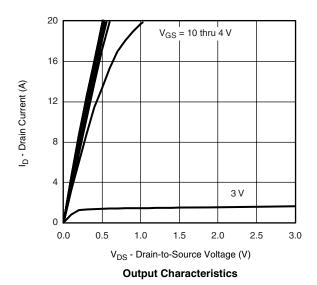
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static			<u> </u>	<u>'I</u>			
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.0		3.0	V	
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V		1			
	I <sub>DSS</sub>	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 85 ^{\circ}\text{C}$			5	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	20			Α	
	В	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 4.9 A		0.029		0	
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V}, I_D = 4.4 \text{ A}$		0.035		Ω	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 10 \text{ V}, I_D = 4.9 \text{ A}$		19		S	
Diode Forward Voltage <sup>a</sup>	$V_{SD}$	I <sub>S</sub> = 1.1 A, V <sub>GS</sub> = 0 V		0.8	1.2	V	
Dynamic <sup>b</sup>	I I		-1	1			
Total Gate Charge	$Q_g$			10	20		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 4.9 \text{ A}$		1.9		nC	
Gate-Drain Charge	$Q_{gd}$			1.6		1	
Gate Resistance	$R_g$	f = 1 MHz		14		Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			10	15		
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 15 $\Omega$		10	15		
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 1$ A, $V_{GEN} = 10$ V, $R_g = 6$ $\Omega$		27	40	ns	
Fall Time	t <sub>f</sub>			10	15		
Source-Drain Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 1.1 A, dI/dt = 100 A/μs		20	60		

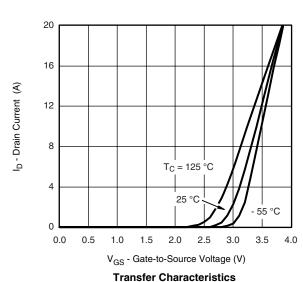
### Notes:

- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

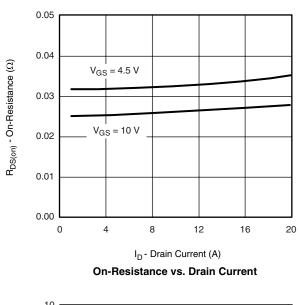
## TYPICAL CHARACTERISTICS $T_J$ = 25 °C, unless otherwise noted

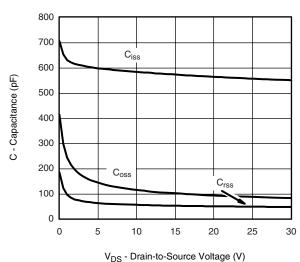


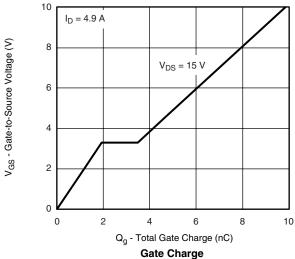




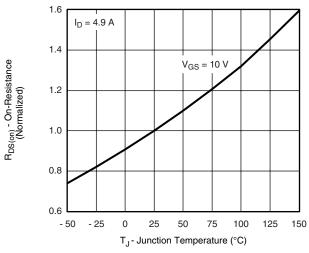
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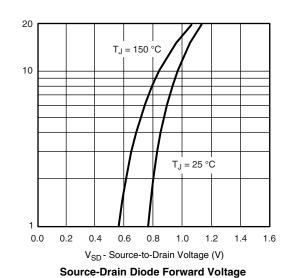




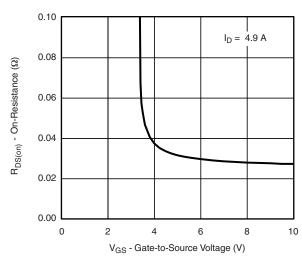


Capacitance





On-Resistance vs. Junction Temperature

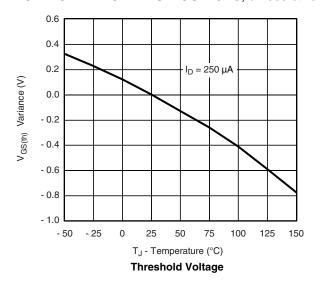


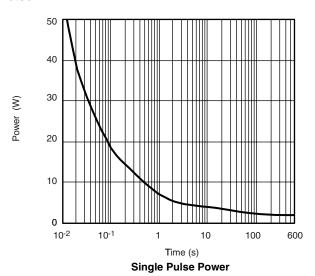
On-Resistance vs. Gate-to-Source Voltage

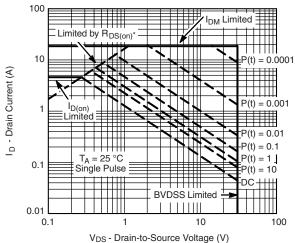
I<sub>S</sub> - Source Current (A)



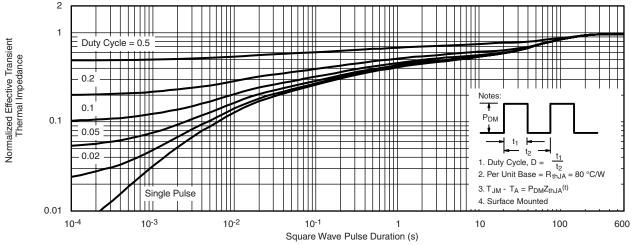
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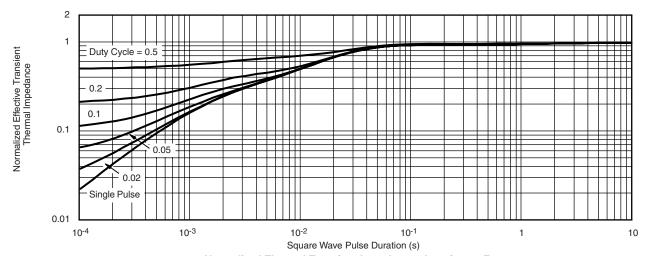
\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified **Safe Operating Area** 



Normalized Thermal Transient Impedance, Junction-to-Ambient



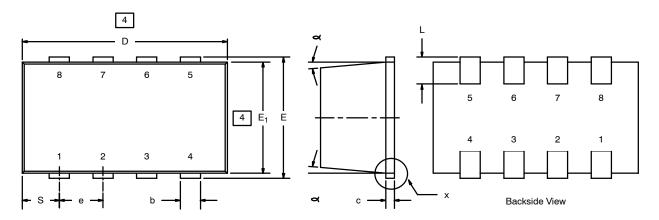
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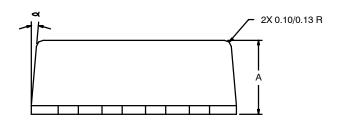


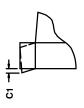
Normalized Thermal Transient Impedance, Junction-to-Foot



## DFN 3x2







**DETAIL X** 

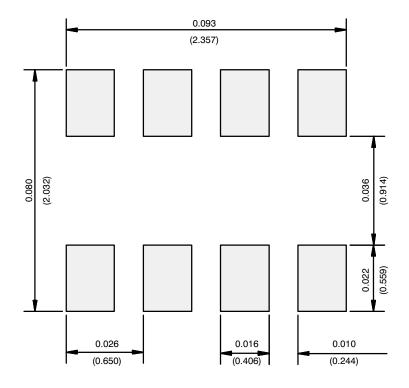
#### NOTES:

- 1. All dimensions are in millimeaters.
- 2. Mold gate burrs shall not exceed 0.13 mm per side.
- Leadframe to molded body offset is horizontal and vertical shall not exceed 0.08 mm.
- 4. Dimensions exclusive of mold gate burrs.
- 5. No mold flash allowed on the top and bottom lead surface.

	MILLIMETERS			INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	1.00	-	1.10	0.039		0.043	
b	0.25	0.30	0.35	0.010	0.012	0.014	
С	0.1	0.15	0.20	0.004	0.006	0.008	
c1	0	_	0.038	0	-	0.0015	
D	2.95	3.05	3.10	0.116	0.120	0.122	
Е	1.825	1.90	1.975	0.072	0.075	0.078	
E <sub>1</sub>	1.55	1.65	1.70	0.061	0.065	0.067	
е	0.65 BSC			0.0256 BSC			
L	0.28	-	0.42	0.011	-	0.017	
S	0.55 BSC			0.022 BSC			
4	5°Nom			5°Nom			
ECN: C-03528—Rev. F, 19-Jan-04 DWG: 5547							



## **RECOMMENDED MINIMUM PADS FOR DFN3x2**



Recommended Minimum Pads Dimensions in Inches/(mm)



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